

Notice of References Cited	Application/Control No. 10/574,583		Applicant(s)/Patent Under Reexamination MATSUMOTO ET AL.	
	Examiner JAIME M. GREENE		Art Unit 1634	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0127904	06-2006	Segawa et al.	435/006
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Lee, et al. IEEE-NANO 2003, Third IEEE Conference on Nanotechnology, 12-14 Aug. 2003; .2: 729-732.
	V	Chou, et al. Biophys J. 2002 October; 83(4): 2170-2179.
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.